# **MOSFET** – Power, Single, P-Channel, Trench, ESD Protected, SC-88

## 12 V, 3.3 A

## Features

- Leading Trench Technology for Low R<sub>DS(ON)</sub> Extending Battery Life
- SC-88 Small Outline (2x2 mm, SC70-6 Equivalent)
- Gate Diodes for ESD Protection
- NV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## Applications

- High Side Load Switch
- Cell Phones, Computing, Digital Cameras, MP3s and PDAs

## **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

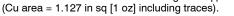
Param	Symbol	Value	Units		
Drain-to-Source Voltage	V <sub>DSS</sub>	-12	V		
Gate-to-Source Voltage	V <sub>GS</sub>	±12	V		
Continuous Drain	Steady	T <sub>A</sub> = 25 °C	Ι <sub>D</sub>	-2.7	А
Current (Note 1)	State	T <sub>A</sub> = 85 °C		-2.0	
	t ≤ 5 s	T <sub>A</sub> = 25 °C		-3.3	
Power Dissipation (Note 1)	Steady State	$T_A = 25 \ ^{\circ}C$	PD	0.625	W
Pulsed Drain Current	I <sub>DM</sub>	-8.0	А		
Operating Junction and S	T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C		
Source Current (Body Di	IS	-0.8	А		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

## THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State	$R_{\theta JA}$	200	°C/W
Junction-to-Ambient – t $\leq$ 5 s	$R_{\theta JA}$	141	
Junction-to-Lead - Steady State	$R_{\theta JL}$	102	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface mounted on FR4 board using 1 in sq pad size

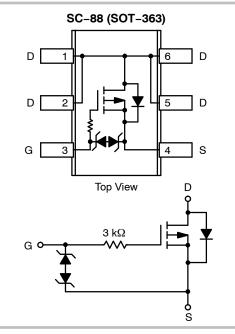




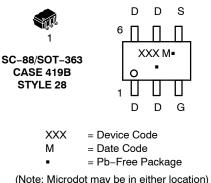
## **ON Semiconductor®**

## www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Тур	I <sub>D</sub> Max
	45 mΩ @ –4.5 V	
–12 V	67 mΩ @ –2.5 V	-3.3 A
	133 mΩ @ −1.8 V	



MARKING DIAGRAM & PIN ASSIGNMENT



## **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 4 of this data sheet.

#### ELECTRICAL CHARACTERISTICS (T<sub>J</sub>=25°C unless otherwise stated)

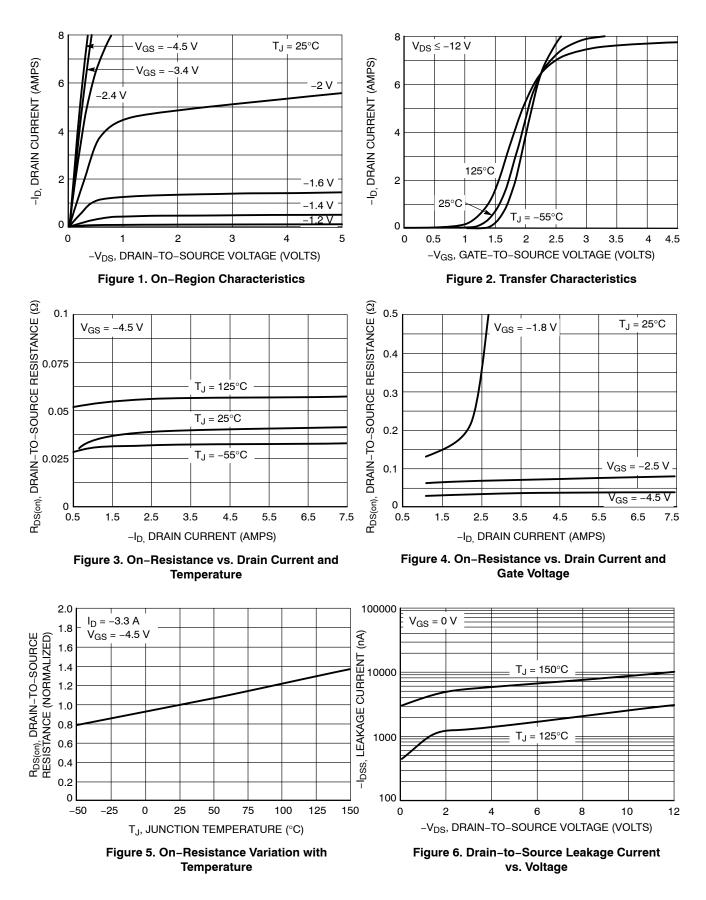
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = -250 $\mu$ A		-12			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				10		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = -9.6 V,	$T_J = 25^{\circ}C$			-1.0	μA
		V <sub>GS</sub> = -9.6 V, V <sub>DS</sub> = 0 V	T <sub>J</sub> = 125°C		-2.5		
Gate-to-Source Leakage Current	$I_{GSS} = 0 V, V_{GS} = \pm 4.5 V$ $V_{DS} = 0 V, V_{GS} = \pm 12 V$				±1.5	μA	
					±10	mA	
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub>	= 100 μA	-0.40		-1.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				3.4		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = -4.5 V, I <sub>D</sub> = -3.3 A			45	60	mΩ
	V <sub>GS</sub> = -2.5 V, I <sub>D</sub> = V <sub>GS</sub> = -1.8 V, I <sub>D</sub> =		<sub>D</sub> = -2.9 A		67	90	
			<sub>D</sub> = -1.0 A		133	160	
Forward Transconductance	9FS	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -3.3 A			15		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				850		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = -12 V			170		
Reverse Transfer Capacitance	C <sub>RSS</sub>	• 03 -			110		
Total Gate Charge	Q <sub>G(TOT)</sub>				8.6		nC
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = -4.5 V, V <sub>I</sub> I <sub>D</sub> = -3.	<sub>DS</sub> = -5.0 V, 3 A		1.3		
Gate-to-Drain Charge	Q <sub>GD</sub>				2.2		
Gate Resistance	R <sub>G</sub>				3000		Ω
SWITCHING CHARACTERISTICS (No	te 3)						
Turn-On Delay Time	t <sub>d(ON)</sub>				0.86		μs
Rise Time	t <sub>r</sub>	$V_{GS}$ = -4.5 V, $V_{DD}$ = -6.0 V, I <sub>D</sub> = -1.0 A, R <sub>G</sub> = 6.0 $\Omega$			1.5		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				3.5		
Fall Time	t <sub>f</sub>				3.9		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS (Note 2	2)					
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V.	$T_J = 25^{\circ}C$		-0.85	-1.2	V
	$V_{SD}$ $V_{GS} = 0 V,$ $I_{S} = -3.3 A$		T <sub>J</sub> = 125°C		-0.7		

 $\begin{tabular}{|c|c|c|c|c|c|c|} \hline I_S = -3.3 \ A & T_J = 125^\circ C & -0.7 \\ \hline Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. \\ \hline Product parametric performance may not be indicated by the Electrical Characteristics if operated under different conditions. \\ \hline Product parametric performance may not be indicated by the Electrical Characteristics if operated under different conditions. \\ \hline Product parametric performance may not be indicated by the Electrical Characteristics if operated under different conditions. \\ \hline Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. \\ \hline Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. \\ \hline Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. \\ \hline Product performance may not perform the test performance may not be indicated by the Electrical Characteristics if operated under different conditions. \\ \hline Product performance may not perform the test perform the test performan$ 

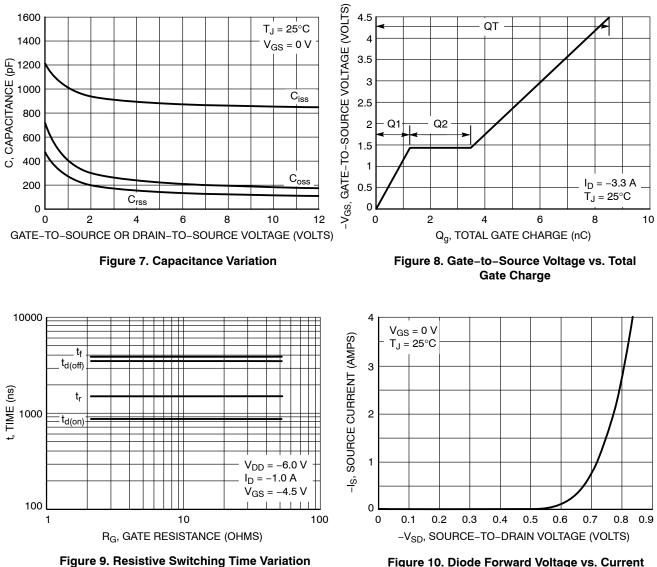
2. Pulse Test: pulse width  $\leq$  300 $\mu$ s, duty cycle  $\leq$  2%.

3. Switching characteristics are independent of operating junction temperatures.

## TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)



## TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

## **ORDERING INFORMATION**

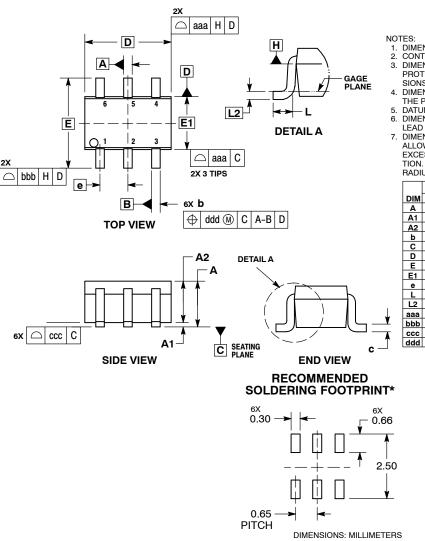
Device	Marking	Package	Shipping <sup>†</sup>	
NTJS3151PT1G	TJ			
NTJS3151PT2G	TJ	SC-88 (Pb-Free)	3000 / Tape & Reel	
NVJS3151PT1G*	VTJ			

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

\*NV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

### PACKAGE DIMENSIONS

SC-88/SC70-6/SOT-363 CASE 419B-02 ISSUE Y



- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH,
- PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRU-SIONS, OR GATE BURRS SHALL NOT EXCEED 0.20 PER END. DIMENSIONS D AND E1 AT THE OUTERMOST EXTREMES OF
- THE PLASTIC BODY AND DATUM H. DATUMS A AND B ARE DETERMINED AT DATUM H. DIMENSIONS b AND C APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.08 AND 0.15 FROM THE TIP.
- DIMENSION & DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 TOTAL IN EXCESS OF DIMENSION 6 AT MAXIMUM MATERIAL CONDI-TION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE FOOT.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α			1.10			0.043	
A1	0.00		0.10	0.000		0.004	
A2	0.70	0.90	1.00	0.027	0.035	0.039	
b	0.15	0.20	0.25	0.006	0.008	0.010	
С	0.08	0.15	0.22	0.003	0.006	0.009	
D	1.80	2.00	2.20	0.070	0.078	0.086	
Е	2.00	2.10	2.20	0.078	0.082	0.086	
E1	1.15	1.25	1.35	0.045	0.049	0.053	
е	(	0.65 BS	С	0.026 BSC			
L	0.26	0.36	0.46	0.010	0.014	0.018	
L2	0.15 BSC			0.006 BSC			
aaa	0.15			0.006			
bbb	0.30			0.012			
CCC	0.10			0.004			
ddd	0.10				0.004		

STYLE 28: PIN 1. DRAIN 2. DRAIN 3. GATE

## 4. SOURCE 5. DRAIN

DRAIN 6.

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and

Mounting Techniques Reference Manual, SOLDERRM/D.

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